

**Search Notes**

Application/Control No.

10/555,063

Examiner

shih-wen hsieh

Applicant(s)/Patent under  
Reexamination

IWASAKI, MITSUTAKA

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	29,30,33 32,85,86	1/2/2008	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search (see attached)	1/2/2008	SWH